

**Notic of References Cited**

Application/Control No.

09/674,522

Applicant(s)/Patent Under  
Reexamination  
FUJII, TAKEHIRO

Examiner

Joseph Nguyen

Art Unit

2815

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*		Document Number	Date	Name	Classification	
		Country Code-Number-Kind Code	MM-YYYY			
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**NON-PATENT DOCUMENTS**

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